

Activity classification for real-time wearable systems : effect of window length, sampling frequency and number of features on classifier performance

Allik, Ardo; Pilt, Kristjan; Karai, Deniss; Fridolin, Ivo; Leier, Mairo; Jervan, Gert 2016 IEEE EMBS Conference on Biomedical Engineering and Sciences (IECBES) : Kuala Lumpur, 4-8 December 2016 / p. 460-464 : ill
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Advancing novel physical fatigue assessment and human activity monitoring methods towards personalized feedback with wearable sensors = Kantavatel seadmetel põhinevate füüsilise väsimuse hindamise ning inimese aktiivsuse monitoorimise meetodite arendamine personaalseks tagasisideks

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Analog integrated circuits and signal processing

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An approach to system-level design for test

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Automated minimization of concurrent online checkers for network-on-chips

Saltarelli, Pietro; Niazmand, Behrad; Hariharan, Ranganathan; Raik, Jaan; Jervan, Gert; Hollstein, Thomas 10th International Symposium on Reconfigurable and Communication-centric Systems-on-Chip (ReCoSoC 2015) : Bremen, 29 June - 1 July 2015 2015 / [8] p. : ill <http://dx.doi.org/10.1109/ReCoSoC.2015.7238079>

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Tagel, Mihkel; Ellervee, Peeter; Hollstein, Thomas; Jervan, Gert Proceedings of the 2011 IEEE Symposium on Design and Diagnostics of Electronic Circuits and Systems : April 13-15, 2011, Gottbus, Germany 2011 / p. 237-242 : ill <https://www.semanticscholar.org/paper/Communication-modelling-and-synthesis-for-NoC-based-Tagel-Ellervee/71f9595d88ed06b63367b87188b218fe6da6bd97>

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Tagel, Mihkel; Ellervee, Peeter; Hollstein, Thomas; Jervan, Gert Info- ja kommunikatsioonitehnoloogia doktorikooli IKTDK viienda aastakonverentsi artiklite kogumik : 25.-26. novembril 2011, Nelijärve 2011 / p. 75-78 : ill

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